## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination DEGUCHI ET AL. | Examiner | Art Unit | Emest G. Therkom | 1723 | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,942,793 B2	09-2005	Ito et al.	210/198.2
*	В	US-6,989,129 B2	01-2006	Licklider et al.	422/70
*	U	US-6,502,448 B1	01-2003	Rapkin, Edward	73/1.03
*	ם	US-6,235,197 B1	05-2001	Anderson et al.	. 210/635
*	ш	US-5,958,227 A	09-1999	Uematsu, Gen-ichi	210/198.2
*	F	US-5,935,443 A	08-1999	Anderson et al.	210/656
*	G	US-2005/0194318 A1	09-2005	Ozbal et al.	210/656
*	H	US-4,158,630	06-1979	Steams, Stanley D.	210/198.2
	1	US-			
	J	US-			
	к	US-			
	L	US-	r II		
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.